

**Notice of References Cited**

Application/Control No.

10/602,359

Applicant(s)/Patent Under  
Reexamination  
TSYBAKOV ET AL.

Examiner

Andrew C. Lee

Art Unit

2476

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**U.S. PATENT DOCUMENTS**

*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Name	Classification
*	A	US-7,352,796	04-2008	von der Embse, Urbain Alfred	375/146
*	B	US-6,930,981	08-2005	Gopalakrishnan et al.	370/252
*	C	US-2002/0110101	08-2002	Gopalakrishnan et al.	370/335
*	D	US-2002/0067692	06-2002	Yun et al.	370/209
*	E	US-7,218,617	05-2007	Usuda et al.	370/320
*	F	US-2005/0050427	03-2005	Jeong et al.	714/755
*	G	US-6,834,047	12-2004	Yoon et al.	370/342
*	H	US-7,599,440	10-2009	Won et al.	375/260
*	I	US-6,473,619	10-2002	Kong et al.	455/456.1
*	J	US-6,700,881	03-2004	Kong et al.	370/335
*	K	US-2006/0209674	09-2006	Chen et al.	370/209
*	L	US-2005/0084112	04-2005	Kim et al.	380/268
*	M	US-7,319,690	01-2008	Wu et al.	370/342

**FOREIGN PATENT DOCUMENTS**

*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Country	Name	Classification
	N					
	O					
	P					
	Q					
	R					
	S					
	T					

**NON-PATENT DOCUMENTS**

*		Include as applicable: Author, Title Date, Publisher, Edition or Volume, Pertinent Pages)				
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	V					
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	X					

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